

**Search Notes**

Application/Control No.

10/694,061

Examiner

Jason M. Han

Applicant(s)/Patent under  
Reexamination

YOSHIHARA, SHIGEO

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	8, 11, 13, 88, 234	3/22/2006	JMH
348	14.02	3/22/2006	JMH
348	370-371	3/22/2006	JMH
348	552	3/22/2006	JMH
396	157-158	3/22/2006	JMH
396	164	3/22/2006	JMH
396	182	3/22/2006	JMH
396	429	3/22/2006	JMH
455	74	3/22/2006	JMH
455	127.1	3/22/2006	JMH
455	344	3/22/2006	JMH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
EAST (US-PGPUB) - See Interference Printout		3/22/2006	JMH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search Update - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	3/22/2006	JMH